

**INFORMATION DISCLOSURE
CITATION**

Atty. Docket No.: D-43378-01

Serial No.: 09/657,679

Applicants: Joe Milton Bowen, Marc Alan Edlein, and Ram K. Ramesh

Filing Date: September 8, 2000

Group: *

U.S. PATENT DOCUMENTS

Examiner Initials		Document Number	Date	Name	Class	Sub Class	Filing Date If Appropriate
<i>Sm</i>	1.	H304	07/07/87	Vorrier et al	522	92	
	2.	RE. 35,203	04/09/96	Wakalopoulos	250	492.3	
	3.	3,850,675	11/26/74	Miller	117	93.31	
	4.	3,933,407	01/20/76	Tu et al	350	61	
	5.	3,936,557	02/03/76	Watt	428	211	
	6.	3,978,260	08/31/76	Dobbins et al	428	204	
	7.	4,064,296	12/20/77	Bornstein et al	428	35	
	8.	4,070,497	01/24/78	Wismer et al	427	44	
	9.	4,197,344	04/08/80	Tshudy	428	212	
	10.	4,309,452	01/05/82	Sachs	427	44	
	11.	4,410,560	10/18/83	Kosterka	427	44	
	12.	4,439,480	03/27/84	Sachs et al	428	161	
	13.	4,647,475	03/03/87	Inukai et al	427	44	
	14.	4,842,906	06/27/89	Ekdahl et al	428	34.2	
	15.	5,070,121	12/03/91	Hinterwaldner et al	524	31	
	16.	5,084,344	01/28/92	Harada et al	428	334	
	17.	5,330,799	07/19/94	Sandor et al	427	510	
	18.	5,379,697	01/10/95	Ertl	101	424.1	
	19.	B1 5,407,708	04/08/97	Lovin et al	427	493	
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	24.	5,744,248	04/28/98	Meixner et al	428	482	
	25.	5,763,048	06/09/98	Takahashi	428	147	
<i>Sm</i>	26.	5,945,183	08/31/99	Johnson	428	34.9	

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		Document Number	Date	Country	Class	Sub-Class	Translation	
							Yes	No
<i>Sm</i>	1.	0 089 629 A3	09/28/83	EPO				
<i>Sm</i>	2.	0 544 052 B1	06/02/93	EPO				

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4.	57-059968	04/10/82	JP			X
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6.	9-302264	11/25/97	JP			X
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2.	Davis et al, "Chemistry Considerations for Low-Voltage EB Applications," RadTech Report, pp. 18-20, September/October 1996.
3.	Dionne, "Can the energy-curing industry cash in on food-packaging opportunities?" Converting Magazine's Flex-Pack Management, Vol. 4, No. 1, pp. 2-3 (January 1, 1998).
4.	Dionne, "UV/EB Curing stakes a claim on flexo-printed food packaging" Converting Magazine's Flex-Pack Management, p. 3 (February 1, 1998).
5.	Clinkunbroomer, "Though the Future is Bright for UV Inks, Wide Web Flexo Market Remains Elusive," American Ink Maker, pp. 23-26 (Sept. 1998).
6.	Harris, "UV Coating - beyond stick and shine," FlexoTech, pp. 21-22 (June 1998).
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8.	Pierce & Stevens Corp., Miracure EB Curable Coatings, Product Brochure, "Formulated for Success: Coatings & Adhesives for Packaging and Graphic Arts" (November 1998).
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10.	Lauppi et al, "Advantages of Low Voltage Electron Beam Processing (80 kV - 110 kV)," Europe '99 RadTech Conference Proceedings, Berlin, Germany, pp. 357-366 (November 8-10, 1999).
11.	Mcintyre, "Total Package Concept: Electron Beam Technology for Barrier, Adhesive, and Overcoat Applications," Presented at Future-Pak '95 (20 pages) (Sept. 13-15, 1995).
12.	Wakalopulos, "Low Voltage or Ultra Low Voltage? . . .," RADTECH REPORT, pp. 10-15 (July/August 1998).
13.	Fletcher, "New Lower-Voltage EB Systems for Curing Polymers and Coatings," Journal of Coatings Technology, Vol. 65, No. 822, pgs. 61-63 (July 1993).
14.	Leach et al, <u>The Printing Ink Manual</u> , Chapter 11, pp. 636-677 (Fifth Ed., Kluwer Academic Publishers 1993).

EXAMINER

Date Considered

*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.